


<b>Search Notes</b>  	<b>Application/Control No.</b>  10586866	<b>Applicant(s)/Patent Under Reexamination</b>  YONEZAWA ET AL.
	<b>Examiner</b>  Stephen M Hepperle	<b>Art Unit</b>  3753

SEARCHED			
Class	Subclass	Date	Examiner
137	599.18, 601.2, 513.5, 523	9/08	SMH
Updated search		1/09	SMH
Updated search		8/09	SMH
137	901		
Updated search		2/10	SMH
137	454.5		
91	443		

SEARCH NOTES		
Search Notes	Date	Examiner
EAST including citation and inventor search	9/08	SMH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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